

**Search Notes**

Application/Control No.

10/810,672

Examiner

TRONG PHAN

Applicant(s)/Patent under  
Reexamination

FUJITO ET AL.

Art Unit

2827

**SEARCHED**

Class	Subclass	Date	Examiner
365	51	10/12/2005	TP
	63		
	203.03		
	230.06		
	185.05		
	185.11		
	185.21		
	185.29		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	10/12/2005	TP

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner